# MOSFET - Dual, P-Channel (-1.5 V), Specified, POWERTRENCH ${ }^{\circledR}$ <br> -20 V, -0.83 A, $0.5 \Omega$ <br> <br> FDY1002PZ 

 <br> <br> FDY1002PZ}

## General Description

These P-Channel Logic Level MOSFETs are produced using onsemi's advanced POWERTRENCH process that has been especially tailored to minimize the on-state resistance and yet maintain low gate charge for superior switching performance. These devices are well suited for all applications where small size is desireable but especially low cost DC/DC conversion in battery powered systems.

This Dual P-Channel MOSFET has been designed using onsemi's advanced Power Trench process to optimize the $\mathrm{r}_{\mathrm{DS}(\mathrm{on})} @ \mathrm{~V}_{\mathrm{GS}}=$ -1.5 V .

## Features

- $\operatorname{Max} \mathrm{r}_{\mathrm{DS}(o n)}=0.5 \Omega$ at $\mathrm{V}_{\mathrm{GS}}=-4.5 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=-0.83 \mathrm{~A}$
- $\operatorname{Max} \mathrm{r}_{\mathrm{DS}(\mathrm{on})}=0.7 \Omega$ at $\mathrm{V}_{\mathrm{GS}}=-2.5 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=-0.70 \mathrm{~A}$
- $\operatorname{Max} \mathrm{r}_{\mathrm{DS}(\mathrm{on})}=1.2 \Omega$ at $\mathrm{V}_{\mathrm{GS}}=-1.8 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=-0.43 \mathrm{~A}$
- $\operatorname{Max} \mathrm{r}_{\mathrm{DS}(o n)}=1.8 \Omega$ at $\mathrm{V}_{\mathrm{GS}}=-1.5 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=-0.36 \mathrm{~A}$
- HBM ESD Protection Level $=1400 \mathrm{~V}$ (Note 1)
- This Device is $\mathrm{Pb}-$ Free and is RoHS Compliant


## Application

- Li-Ion Battery Pack


## NOTE:

1. The diode connected between the gate and source serves only as protection against ESD. No gate overvoltage rating is implied.

| $\mathrm{V}_{\mathrm{DS}}$ | $\mathrm{r}_{\mathrm{DS} \text { (on) }}$ MAX | $\mathrm{I}_{\mathrm{D}} \mathrm{MAX}$ |
| :---: | :---: | :---: |
| $-20 \mathrm{~V}$ | $0.5 \Omega @-4.5 \mathrm{~V}$ | -0.83 A |
|  | $0.7 \Omega @-2.5 \mathrm{~V}$ |  |
|  | $1.2 \Omega @-1.8 \mathrm{~V}$ |  |
|  | $1.8 \Omega @-1.5 \mathrm{~V}$ |  |



MARKING DIAGRAM


G = Device Code \&2 = 2-Digit Date Code


## ORDERING INFORMATION

See detailed ordering and shipping information on page 6 of this data sheet.

MOSFET MAXIMUM RATINGS $\left(T_{A}=25^{\circ} \mathrm{C}\right.$ unless otherwise noted)

| Symbol | Parameter |  | Ratings | Unit |
| :---: | :--- | :--- | :---: | :---: |
| $\mathrm{V}_{\mathrm{DS}}$ | Drain to Source Voltage | -20 | V |  |
| $\mathrm{~V}_{\mathrm{GS}}$ | Gate to Source Voltage | $\pm 8$ | V |  |
| $\mathrm{I}_{\mathrm{D}}$ | Drain Current | - Continuous (Note 2a) | -0.83 | A |
|  |  | - Pulsed | -1.0 |  |
|  | $\mathrm{P}_{\mathrm{D}}$ | Power Dissipation | (Note 2a) | 0.625 |
|  |  | (Note 2b) | W |  |
|  |  | 0.446 |  |  |

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL CHARACTERISTICS $\left(\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}\right.$ unless otherwise noted)

| Symbol | Parameter | Ratings | Unit |
| :---: | :--- | :---: | :---: |
| $R_{\theta J A}$ | Thermal Resistance, Junction to Ambient (Note 2a) | 200 |  |
| $R_{\theta J C}$ | Thermal Resistance, Junction to Case (Note 2b) | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |  |

2. $R_{\theta J A}$ is determined with the device mounted on a $1 \mathrm{in}^{2}$ oz. copper pad on a $1.5 \times 1.5 \mathrm{in}$. board of FR-4 material. $R_{\theta J c}$ is guaranteed by design while $R_{\theta J A}$ is determined by the user's board design.

a. $200^{\circ} \mathrm{C} / \mathrm{W}$ when mounted on a $1 \mathrm{in}^{2}$ pad of 2 oz copper.
b. $280^{\circ} \mathrm{C} / \mathrm{W}$ when mounted on a minimum pad of 2 oz copper.

ELECTRICAL CHARACTERISTICS $\left(\mathrm{T}_{\mathrm{J}}=25^{\circ} \mathrm{C}\right.$ unless otherwise noted)

| Symbol | Parameter | Test Conditions | Min | Typ | Max | Unit |
| :---: | :--- | :--- | :---: | :---: | :---: | :---: | :---: |


| $\mathrm{BV}_{\mathrm{DSS}}$ | Drain to Source Breakdown Voltage | $\mathrm{I}_{\mathrm{D}}=-250 \mu \mathrm{~A}, \mathrm{~V}_{\mathrm{GS}}=0 \mathrm{~V}$ | -20 | - | - | V |
| :---: | :--- | :--- | :---: | :---: | :---: | :---: |
| $\frac{\Delta \mathrm{BV}_{\mathrm{DSS}}}{\Delta \mathrm{T}_{J}}$ | Breakdown VoItage Temperature Coef- <br> ficient | $\mathrm{I}_{\mathrm{D}}=-250 \mu \mathrm{~A}$, referenced to $25^{\circ} \mathrm{C}$ | - | -11 | - | $\mathrm{mV} /{ }^{\circ} \mathrm{C}$ |
| $\mathrm{I}_{\mathrm{DSS}}$ | Zero Gate Voltage Drain Current | $\mathrm{V}_{\mathrm{DS}}=-16 \mathrm{~V}, \mathrm{~V}_{\mathrm{GS}}=0 \mathrm{~V}$ |  |  |  |  |
| $\mathrm{I}_{\mathrm{GSS}}$ | Gate to Source Leakage Current | $\mathrm{V}_{\mathrm{GS}}= \pm 8 \mathrm{~V}, \mathrm{~V}_{\mathrm{DS}}=0 \mathrm{~V}$ | - | - | -1 | $\mu \mathrm{~A}$ |

ON CHARACTERISTICS (Note 3)

| $\mathrm{V}_{\mathrm{GS}}(\mathrm{th})$ | Gate to Source Threshold Voltage | $\mathrm{V}_{\mathrm{GS}}=\mathrm{V}_{\mathrm{DS}}, \mathrm{I}_{\mathrm{D}}=-250 \mu \mathrm{~A}$ | -0.4 | -0.7 | -1.0 | V |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\frac{\Delta \mathrm{V}_{\mathrm{GS}(\mathrm{th})}}{\Delta \mathrm{T}_{\mathrm{J}}}$ | Gate to Source Threshold Voltage Temperature Coefficient | $\mathrm{I}_{\mathrm{D}}=-250 \mu \mathrm{~A}$, referenced to $25^{\circ} \mathrm{C}$ | - | 3 | - | $\mathrm{mV} /{ }^{\circ} \mathrm{C}$ |
| ${ }^{\text {r }}$ DS(on) | Static Drain to Source On-Resistance | $\mathrm{V}_{\mathrm{GS}}=-4.5 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=-0.83 \mathrm{~A}$ | - | 0.28 | 0.5 | $\Omega$ |
|  |  | $\mathrm{V}_{\mathrm{GS}}=-2.5 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=-0.70 \mathrm{~A}$ | - | 0.36 | 0.7 |  |
|  |  | $\mathrm{V}_{\mathrm{GS}}=-1.8 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=-0.43 \mathrm{~A}$ | - | 0.47 | 1.2 |  |
|  |  | $\mathrm{V}_{\mathrm{GS}}=-1.5 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=-0.36 \mathrm{~A}$ | - | 0.62 | 1.8 |  |
|  |  | $\mathrm{V}_{\mathrm{GS}}=-4.5 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=-0.83 \mathrm{~A}, \mathrm{~T}_{\mathrm{J}}=125^{\circ} \mathrm{C}$ | - | 0.39 | 0.85 |  |
| gFs | Forward Transconductance | $\mathrm{V}_{\mathrm{DD}}=-5 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=-0.83 \mathrm{~A}$ | - | 2 | - | S |

DYNAMIC CHARACTERISTICS

| $\mathrm{C}_{\text {iss }}$ | Input Capacitance | $\mathrm{V}_{\mathrm{DS}}=-10 \mathrm{~V}, \mathrm{~V}_{\mathrm{GS}}=0 \mathrm{~V}, \mathrm{f}=1 \mathrm{MHz}$ | - | 100 | 135 | pF |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{C}_{\text {oss }}$ | Output Capacitance |  | - | 23 | 35 | pF |
| $\mathrm{C}_{\text {rss }}$ | Reverse Transfer Capacitance |  | - | 18 | 30 | pF |

SWITCHING CHARACTERISTICS (Note 3)

| $\mathrm{t}_{\mathrm{d} \text { (on) }}$ | Turn-On Delay Time | $\begin{aligned} & \mathrm{V}_{\mathrm{DD}}=-10 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=-0.83 \mathrm{~A} \mathrm{~V}_{\mathrm{GS}}=-4.5 \mathrm{~V}, \\ & \mathrm{R}_{\mathrm{GEN}}=6 \Omega \end{aligned}$ | - | 3.5 | 10 | ns |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{t}_{\mathrm{r}}$ | Rise Time |  | - | 2.9 | 10 | ns |
| $\mathrm{t}_{\mathrm{d} \text { (off) }}$ | Turn-Off Delay Time |  | - | 23 | 37 | ns |
| $\mathrm{t}_{\mathrm{f}}$ | Fall Time |  | - | 13 | 23 | ns |
| $\mathrm{Q}_{\mathrm{g}}$ | Total Gate Charge | $\mathrm{V}_{\mathrm{DD}}=-10 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=-0.83 \mathrm{~A} \mathrm{VGS}=-4.5 \mathrm{~V}$ | - | 2.2 | 3.1 | nC |
| $\mathrm{Q}_{\mathrm{gs}}$ | Gate to Source Charge |  | - | 0.3 | - | nC |
| $\mathrm{Q}_{\mathrm{gd}}$ | Gate to Drain "Miller" Charge |  | - | 0.6 | - | nC |

DRAIN-SOURCE DIODE CHARACTERISTICS AND MAXIMUM RATING

| $\mathrm{I}_{\mathrm{S}}$ | Maximum Continuous Drain-Source Diode Forward Current | - | - | -0.52 | A |  |
| :---: | :--- | :--- | :---: | :---: | :---: | :---: |
| $\mathrm{~V}_{\mathrm{SD}}$ | Source to Drain Diode Forward Voltage | $\mathrm{V}_{\mathrm{GS}}=0 \mathrm{~V}, \mathrm{I}_{\mathrm{S}}=-0.52 \mathrm{~A}($ Note 3) | - | -1.0 | -1.2 | V |
| $\mathrm{t}_{\mathrm{rr}}$ | Reverse Recovery Time | $\mathrm{I}_{\mathrm{F}}=-0.83 \mathrm{~A}, \mathrm{dI}_{\mathrm{F}} / \mathrm{dt}=100 \mathrm{~A} / \mathrm{us}$ | - | 18 | 31 | ns |
| $\mathrm{Q}_{\mathrm{rr}}$ | Reverse Recovery Charge |  | - | 3.8 | 10 | nC |

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.
3. Pulse Test: Pulse Width < 300 us, Duty Cycle $<2.0 \%$.

## TYPICAL ELECTRICAL CHARACTERISTICS

( $T_{J}=25^{\circ} \mathrm{C}$ unless otherwise noted)


Figure 1. On Region Characteristics

NORMALIZED DRAIN TO SOURCE


Figure 3. Normalized On Resistance vs. Junction Temperature


Figure 5. Transfer Characteristics


Figure 2. Normalized On-Resistance vs. Drain Current and Gate Voltage


Figure 4. On-Resistance vs. Gate to Source Voltage


Figure 6. Source to Drain Diode Forward Voltage vs. Source Current

TYPICAL ELECTRICAL CHARACTERISTICS
( $\mathrm{T}_{\mathrm{J}}=25^{\circ} \mathrm{C}$ unless otherwise noted) (continued)


Figure 7. Gate Charge Characteristics


Figure 9. Gate Leakage Current vs. Gate to Source Voltage


Figure 8. Capacitance vs. Drain to Source Voltage


Figure 10. Forward Bias Safe Operating Area


Figure 11. Single Pulse Maximum Power Dissipation

## TYPICAL ELECTRICAL CHARACTERISTICS

( $\mathrm{T}_{J}=25^{\circ} \mathrm{C}$ unless otherwise noted) (continued)


Figure 12. Junction-to-Ambient Transient Thermal Response Curve

PACKAGE MARKING AND ORDERING INFORMATION

| Device | Device Marking | Package | Reel Size | Tape Width | Shipping $^{\dagger}$ |
| :---: | :---: | :---: | :---: | :---: | :---: |
| FDY1002PZ | G | SOT-563 <br> (Pb-Free) | $7 "$ | 8 mm | $3000 /$ Tape \& Reel |

$\dagger$ For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.


NOTES: UNLESS OTHERWISE SPECIFIED.

A. REFERENCE TO JEDEC MO293.
B. ALL DIMENSIONS ARE IN MILLIMETERS.

C DOES NOT COMPLY JEDEC STANDARD VALUE.
D. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH AND TIE BAR PROTRUSION.
E. DIMENSION AND TOLERANCE AS PER ASME Y14.5-2009.
F. LANDPATTERN RECOMMENDATION GENERATED WITH IPC LANDPATTERN GENERATOR

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